

TOSHIBA Photocoupler GaAs IRed &amp; Photo-Transistor

**TLP137**

Office Machine

Programmable Controllers

AC / DC-Input Module

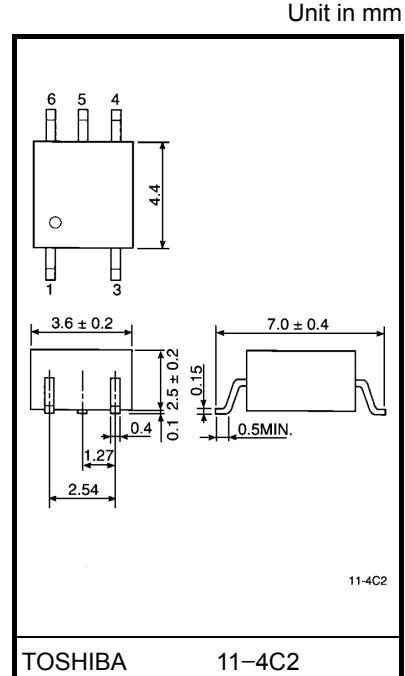
Telecommunication

The TOSHIBA mini flat coupler TLP137 is a small outline coupler, suitable for surface mount assembly.

TLP137 consists of a gallium arsenide infrared emitting diode, optically coupled to a photo transistor, and provides high CTR at low input current.

TLP137 base terminal is for the improvement of speed, reduction of dark current, and enable operation.

- Collector-emitter voltage: 80V(min.)
- Current transfer ratio: 100%(min.)  
Rank BV: 200%(min.)
- Isolation voltage: 3750Vrms(min.)
- UL recognized: UL1577, file No. E67349
- Current transfer ratio

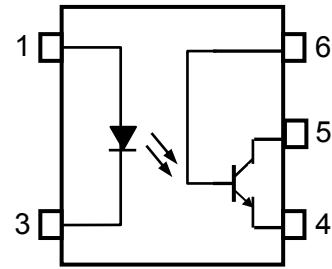


Weight: 0.09 g

| Classifi-<br>cation | Current Transfer Ratio (min.)                  |  | Marking<br>Of<br>Classifi-<br>cation |  |
|---------------------|--|--|--------------------------------------|--|
|                     | Ta = 25°C                                      |  |                                      |  |
|                     | I <sub>F</sub> = 1mA<br>V <sub>CE</sub> = 0.5V | I <sub>F</sub> = 0.5mA<br>V <sub>CE</sub> = 1.5V |                                      |  |
| Rank BV             | 200%   | 100%   | 100% BV                              |  |
| Standard            | 100%   | 50%  | 50% BV, Blank                        |  |

(Note) Application type name for certification test,  
please use standard product type name, i.e.

TLP137 (BV): TLP137

**Pin Configurations (top view)**

- 1 : Anode
- 3 : Cathode
- 4 : Emitter
- 5 : Collector
- 6 : Base

**Absolute Maximum Ratings (Ta = 25°C)**

| Characteristic                                       |   | Symbol               | Rating          | Unit             |
|--|---|----------------------|-----------------|------------------|
| LED  | Forward current                             | I <sub>F</sub>       | 50              | mA               |
|  | Forward current derating (Ta ≥ 53°C)        | ΔI <sub>F</sub> / °C | -0.7            | mA / °C          |
|  | Peak forward current (100μs pulse, 100pps)  | I <sub>FP</sub>      | 1               | A                |
|  | Reverse voltage                             | V <sub>R</sub>       | 5               | V                |
|  | Junction temperature                        | T <sub>j</sub>       | 125             | °C               |
| Detector   | Collector–emitter voltage                   | V <sub>CEO</sub>     | 80              | V                |
|  | Collector–base voltage                      | V <sub>CBO</sub>     | 80              | V                |
|  | Emitter–collector voltage                   | V <sub>ECO</sub>     | 7               | V                |
|  | Emitter–base voltage                        | V <sub>EBO</sub>     | 7               | V                |
|  | Collector current                           | I <sub>C</sub>       | 50              | mA               |
|  | Peak collector current (10ms pulse, 100pps) | I <sub>CP</sub>      | 100             | mA               |
|  | Power dissipation                           | P <sub>C</sub>       | 150             | mW               |
|  | Power dissipation derating (Ta ≥ 25°C)      | ΔP <sub>C</sub> / °C | -1.5            | mW / °C          |
|  | Junction temperature                        | T <sub>j</sub>       | 125             | °C               |
| Storage temperature range                            |   | T <sub>stg</sub>     | -55~125         | °C               |
| Operating temperature range                          |   | T <sub>opr</sub>     | -55~100         | °C               |
| Lead soldering temperature (10s)                     |   | T <sub>sol</sub>     | 260             | °C               |
| Total package power dissipation                      |   | P <sub>T</sub>       | 200             | mW               |
| Total package power dissipation derating (Ta ≥ 25°C) |   | ΔP <sub>T</sub> / °C | -2.0            | mW / °C          |
| Isolation voltage (AC, 1min., RH ≤ 60%)              |   | (Note 1)             | BV <sub>S</sub> | V <sub>rms</sub> |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

(Note 1) Device considered a two terminal device: Pins 1 and 3 shorted together and pins 4, 5 and 6 shorted together.

**Individual Electrical Characteristics (Ta = 25°C)**

| Characteristic                     |                                     | Symbol               | Test Condition  | Min. | Typ. | Max. | Unit |
|------------------------------------|-------------------------------------|----------------------|---|------|------|------|------|
| LED                                | Forward voltage                     | V <sub>F</sub>       | I <sub>F</sub> = 10mA                                     | 1.0  | 1.15 | 1.3  | V    |
|                                    | Reverse current                     | I <sub>R</sub>       | V <sub>R</sub> = 5V                                       | —    | —    | 10   | µA   |
|                                    | Capacitance                         | C <sub>T</sub>       | V = 0, f = 1MHz   | —    | 30   | —    | pF   |
| Detector                           | Collector-emitter breakdown voltage | V <sub>(BR)CEO</sub> | I <sub>C</sub> = 0.5mA                                    | 80   | —    | —    | V    |
|                                    | Emitter-collector breakdown voltage | V <sub>(BR)ECO</sub> | I <sub>E</sub> = 0.1mA                                    | 7    | —    | —    | V    |
|                                    | Collector-base breakdown voltage    | V <sub>(BR)CBO</sub> | I <sub>C</sub> = 0.1mA                                    | 80   | —    | —    | V    |
|                                    | Emitter-base breakdown voltage      | V <sub>(BR)EBO</sub> | I <sub>E</sub> = 0.1mA                                    | 7    | —    | —    | V    |
|                                    | Collector dark current              | I <sub>CEO</sub>     | V <sub>CE</sub> = 48V                                     | —    | 10   | 100  | nA   |
|                                    |                                     |                      | V <sub>CE</sub> = 48V, Ta = 85°C                          | —    | 2    | 50   | µA   |
|                                    | Collector dark current              | I <sub>CER</sub>     | V <sub>CE</sub> = 48V, Ta = 85°C<br>R <sub>BE</sub> = 1MΩ | —    | 0.5  | 10   | µA   |
|                                    | Collector dark current              | I <sub>CBO</sub>     | V <sub>CB</sub> = 10V                                     | —    | 0.1  | —    | nA   |
|                                    | DC forward current gain             | h <sub>FE</sub>      | V <sub>CE</sub> = 5V, I <sub>C</sub> = 0.5mA              | —    | 1000 | —    | —    |
| Capacitance (collector to emitter) |                                     | C <sub>CE</sub>      | V= 0, f = 1MHz  | —    | 12   | —    | pF   |

**Coupled Electrical Characteristics (Ta = 25°C)**

| Characteristic                       | Symbol                               | Test Condition  | Min. | Typ. | Max. | Unit |
|--------------------------------------|--------------------------------------|---|------|------|------|------|
| Current transfer ratio               | I <sub>C</sub> / I <sub>F</sub>      | I <sub>F</sub> = 1mA, V <sub>CE</sub> = 0.5V<br>Rank BV   | 100  | —    | 1200 | %    |
|                                      |                                      |   | 200  | —    | 1200 |      |
| Low input CTR                        | I <sub>C</sub> / I <sub>F(low)</sub> | I <sub>F</sub> = 0.5mA, V <sub>CE</sub> = 1.5V<br>Rank BV | 50   | —    | —    | %    |
|                                      |                                      |   | 100  | —    | —    |      |
| Base photo-current                   | I <sub>PB</sub>                      | I <sub>F</sub> = 1mA, V <sub>CB</sub> = 5V                | —    | 5    | —    | µA   |
| Collector-emitter saturation voltage | V <sub>CE(sat)</sub>                 | I <sub>C</sub> = 0.5mA, I <sub>F</sub> = 1mA              | —    | —    | 0.4  | V    |
|                                      |                                      | I <sub>C</sub> = 1mA, I <sub>F</sub> = 1mA<br>Rank BV     | —    | 0.2  | —    |      |
|                                      |                                      | —   | —    | 0.4  | —    |      |
| Off-state collector current          | I <sub>C(off)</sub>                  | V <sub>F</sub> = 0.7V, V <sub>CE</sub> = 48V              | —    | —    | 10   | µA   |

Coupled Electrical Characteristics ( $T_a = -25\text{--}75^\circ\text{C}$ )

| Characteristic         | Symbol                    | Test Condition                             | Min. | Typ. | Max. | Unit |
|------------------------|---------------------------|--|------|------|------|------|
| Current transfer ratio | $I_C / I_F$               | $I_F = 1\text{mA}, V_{CE} = 0.5\text{V}$   | 50   | —    | —    | %    |
|                        |                           | Rank BV                                    | 100  | —    | —    |      |
| Low input CTR          | $I_C / I_{F(\text{low})}$ | $I_F = 0.5\text{mA}, V_{CE} = 1.5\text{V}$ | —    | 50   | —    | %    |
|                        |                           | Rank BV                                    | —    | 100  | —    |      |

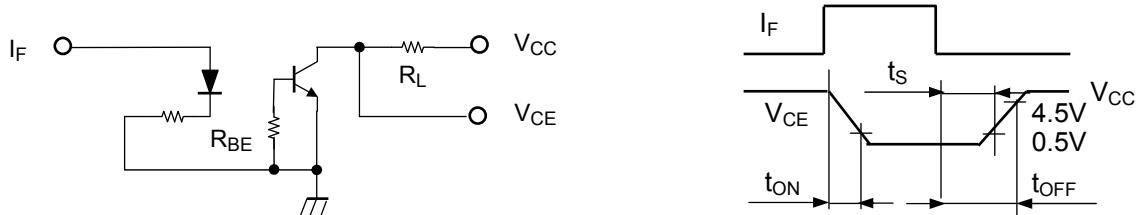
Isolation Characteristics ( $T_a = 25^\circ\text{C}$ )

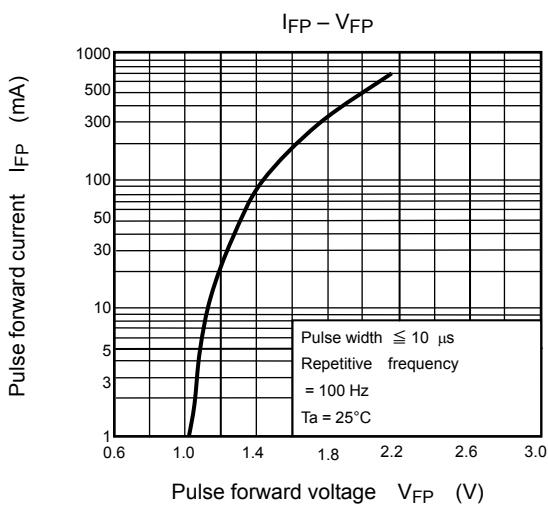
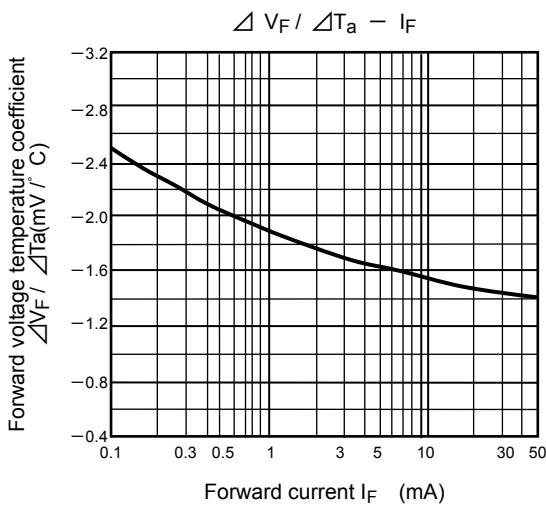
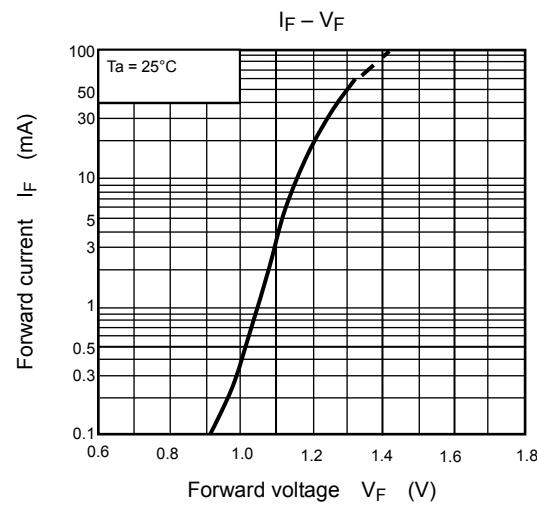
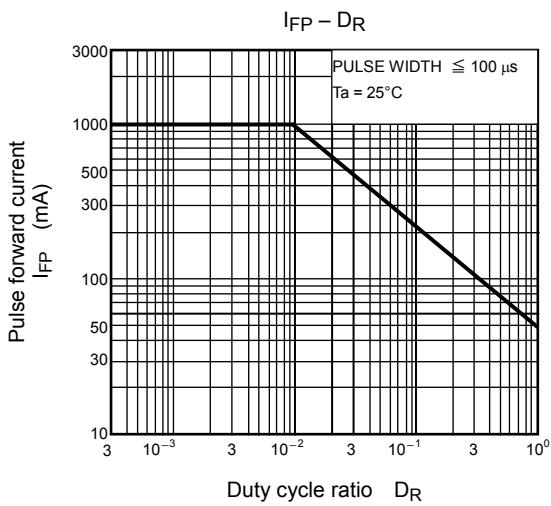
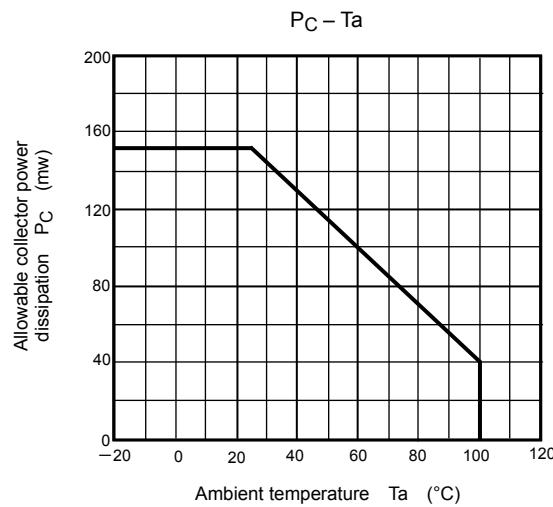
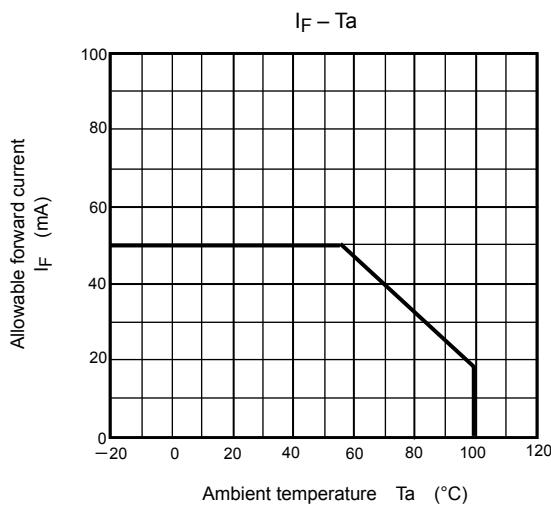
| Characteristic                | Symbol | Test Condition             | Min.               | Typ.      | Max. | Unit          |
|-------------------------------|--------|----------------------------|--------------------|-----------|------|---------------|
| Capacitance (input to output) | $C_S$  | $V_S = 0, f = 1\text{MHz}$ | —                  | 0.8       | —    | pF            |
| Isolation resistance          | $R_S$  | $V = 500\text{V}$          | $5 \times 10^{10}$ | $10^{14}$ | —    | $\Omega$      |
| Isolation voltage             | $BV_S$ | AC, 1 minute               | 3750               | —         | —    | $\text{VRms}$ |
|                               |        | AC, 1 second, in oil       | —                  | 10000     | —    |               |
|                               |        | DC, 1 minute, in oil       | —                  | 10000     | —    | $\text{Vdc}$  |

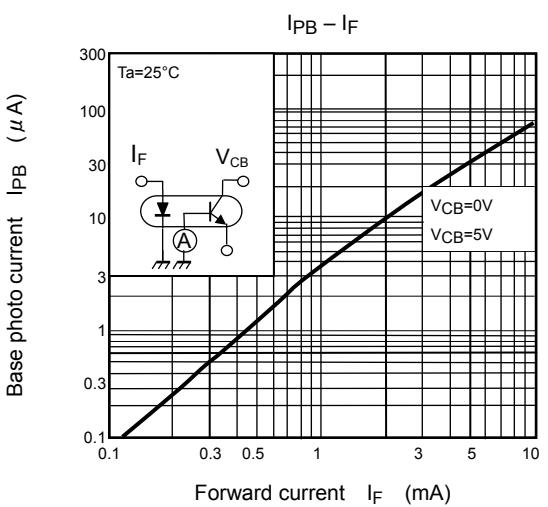
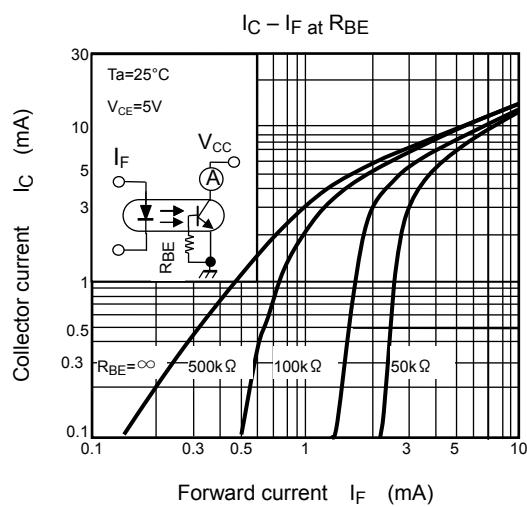
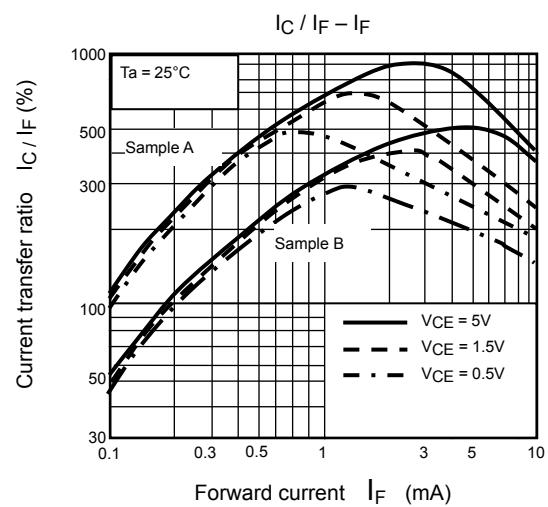
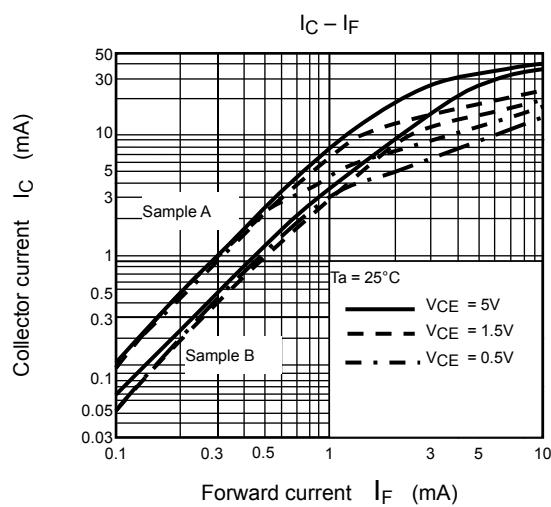
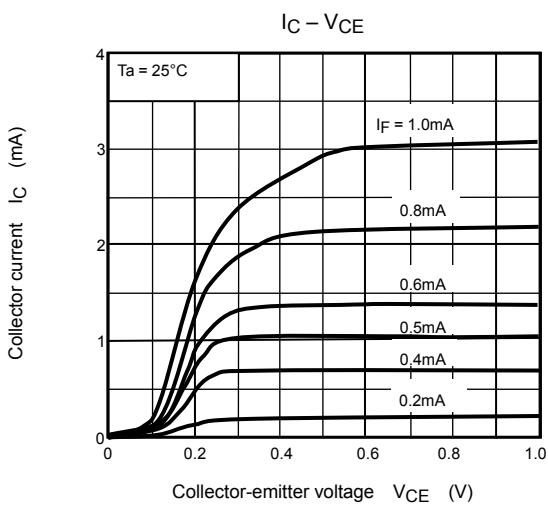
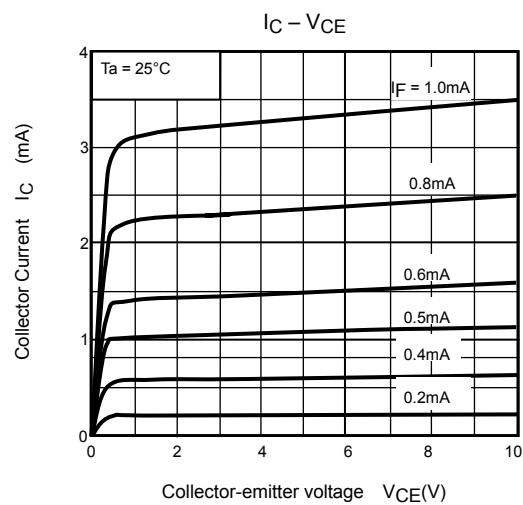
Switching Characteristics ( $T_a = 25^\circ\text{C}$ )

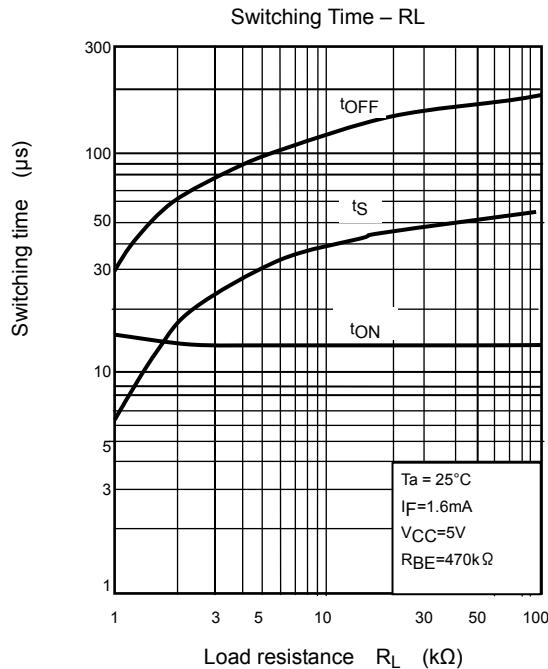
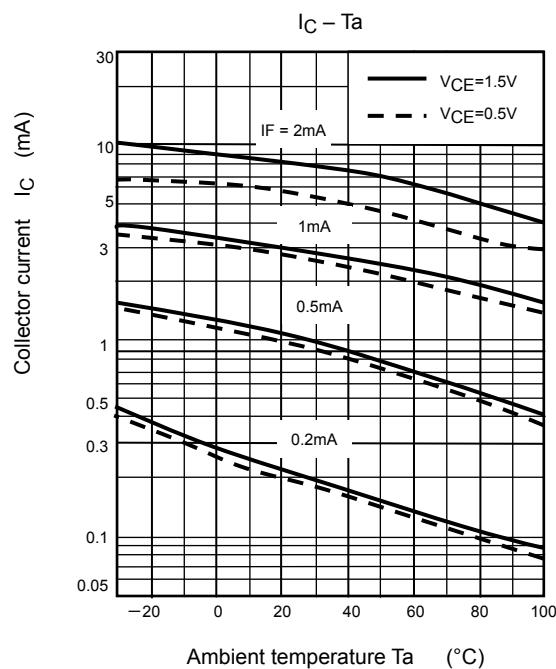
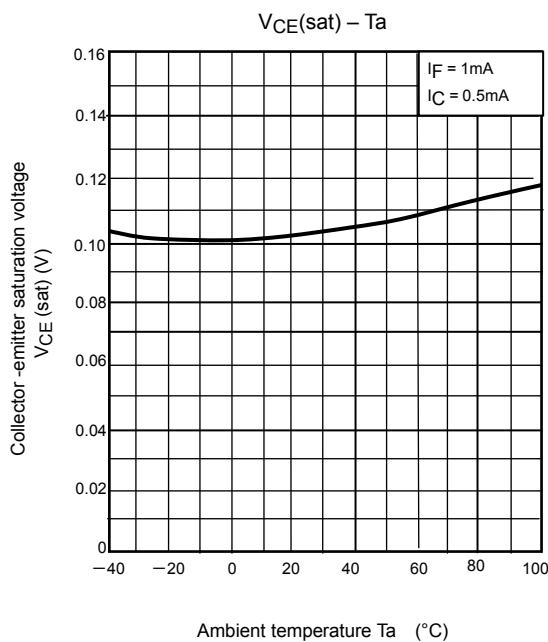
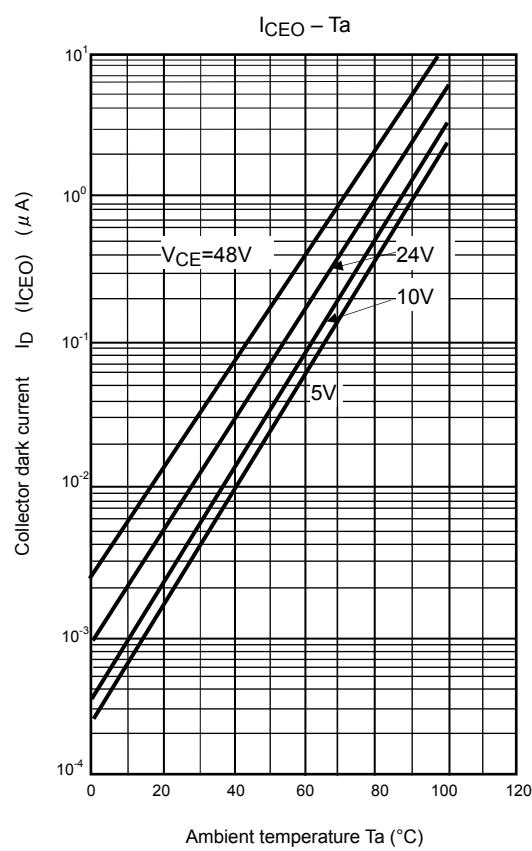
| Characteristic | Symbol    | Test Condition  | Min. | Typ. | Max. | Unit          |
|----------------|-----------|---|------|------|------|---------------|
| Rise time      | $t_r$     | $V_{CC} = 10\text{V}, I_C = 2\text{mA}$<br>$R_L = 100\Omega$  | —    | 8    | —    | $\mu\text{s}$ |
| Fall time      | $t_f$     |   | —    | 8    | —    |               |
| Turn-on time   | $t_{ON}$  |   | —    | 10   | —    |               |
| Turn-off time  | $t_{OFF}$ |   | —    | 8    | —    |               |
| Turn-on time   | $t_{ON}$  | $R_L = 4.7\text{k}\Omega$<br>$R_{BE} = \text{OPEN}$<br>$V_{CC} = 5\text{V}, I_F = 1.6\text{mA}$       | —    | 10   | —    | $\mu\text{s}$ |
| Storage time   | $t_s$     |   | —    | 50   | —    |               |
| Turn-off time  | $t_{OFF}$ |   | —    | 300  | —    |               |
| Turn-on time   | $t_{ON}$  | $R_L = 4.7\text{k}\Omega$<br>$R_{BE} = 470\text{k}\Omega$<br>$V_{CC} = 5\text{V}, I_F = 1.6\text{mA}$ | —    | 12   | —    | $\mu\text{s}$ |
| Storage time   | $t_s$     |   | —    | 30   | —    |               |
| Turn-off time  | $t_{OFF}$ |   | —    | 100  | —    |               |

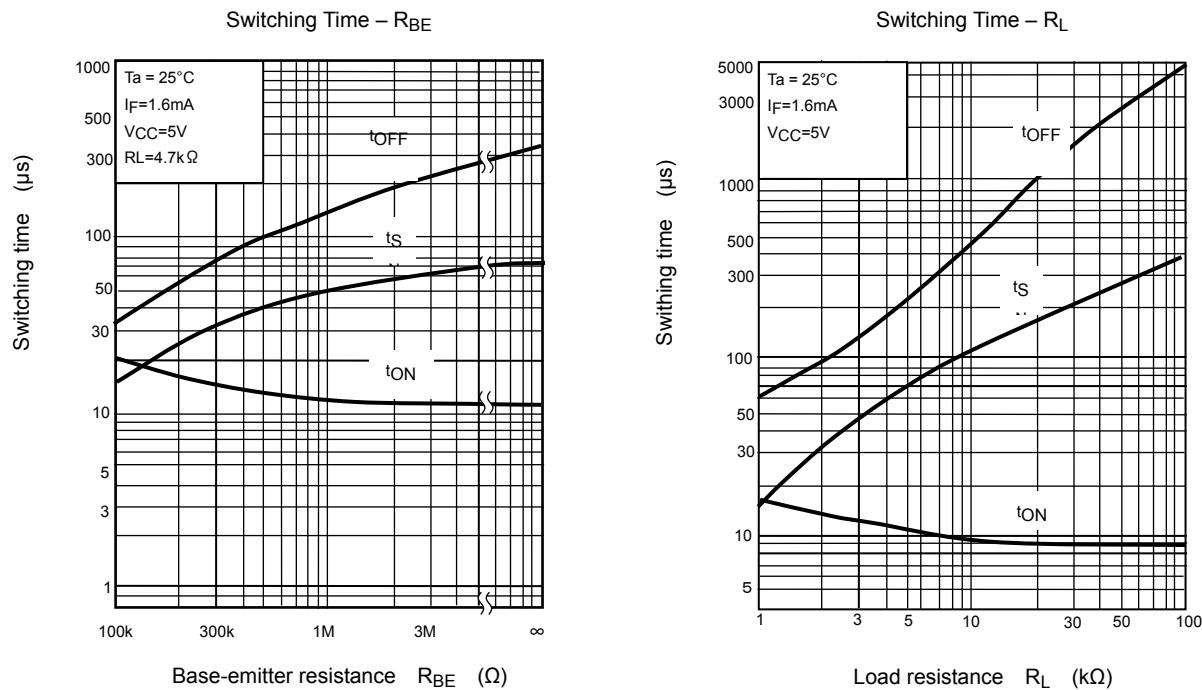
Fig. 1 Switching time test circuit











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